



DST3946DPJ

COMPLEMENTARY NPN/PNP SURFACE MOUNT TRANSISTOR

Features

- Epitaxial Planar Die Construction
- Ideally Suited for Automated Assembly Processes
- Lead, Halogen and Antimony Free, RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Ultra Small Package

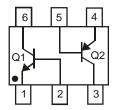
Mechanical Data

- Case: SOT-963
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.0027 grams (approximate)

SOT-963



Top View



Device Schematic

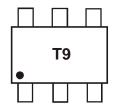
Ordering Information (Note 5)

Device	Packaging	Shipping
DST3946DPJ-7	SOT-963	10.000/Tape & Reel

Notes:

- 1. No purposefully added lead. Halogen and Antimony Free.
- 2. Diodes Inc's "Green" Policy can be found on our website at http://www.diodes.com

Marking Information



T9 = Product Type Marking Code



Maximum Ratings - NPN (Q1) @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V _{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6.0	V
Collector Current – Continuous	Ic	200	mA

Maximum Ratings - PNP (Q2) @T_A = 25°C unless otherwise specified

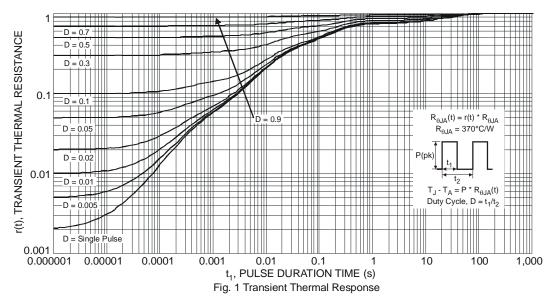
Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5.0	V
Collector Current - Continuous	lc	-200	mA

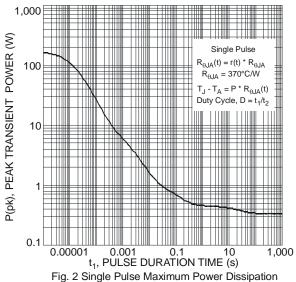
Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 3)	P_{D}	300	mW
Thermal Resistance, Junction to Ambient (Note 3)	$R_{ hetaJA}$	417	°C/W
Operating and Storage Temperature Range	T_J , T_{STG}	-55 to +150	°C

Notes: 3. Device mounted on FR-4 PCB with minimum recommended pad layout.







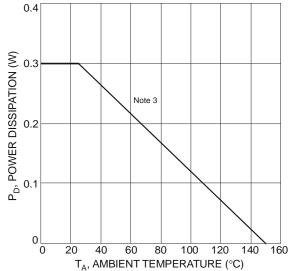


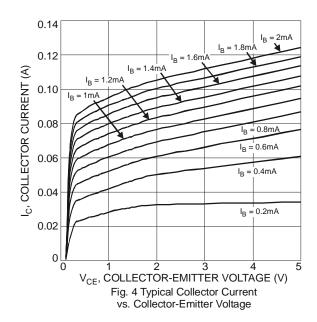
Fig. 3 Power Dissipation vs. Ambient Temperature

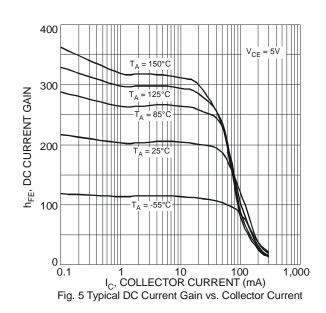


Electrical Characteristics - NPN (Q1) @T_A = 25°C unless otherwise specified

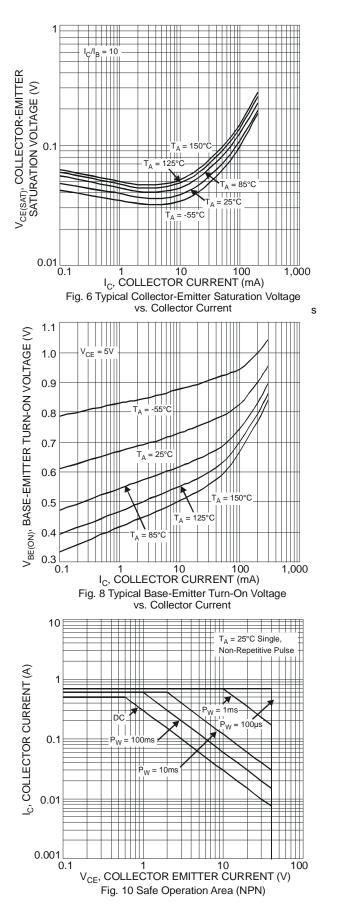
Characteristic	Symbol	Min	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 4)						
Collector-Base Breakdown Voltage	V _{(BR)CBO}	60	_	V	$I_C = 10\mu A, I_E = 0$	
Collector-Emitter Breakdown Voltage (Note 4)	V _{(BR)CEO}	40	_	V	$I_C = 1.0 \text{mA}, I_B = 0$	
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	6.0	_	V	$I_E = 10 \mu A, I_C = 0$	
Collector Cutoff Current	I _{CEX}		50	nA	$V_{CE} = 30V, V_{EB(OFF)} = 3.0V$	
Base Cutoff Current	I_{BL}		50	nA	$V_{CE} = 30V, V_{EB(OFF)} = 3.0V$	
ON CHARACTERISTICS (Note 4)						
		40	_		$I_C = 100 \mu A, V_{CE} = 1.0 V$	
		70	_		$I_C = 1.0 \text{mA}, V_{CE} = 1.0 \text{V}$	
DC Current Gain	h _{FE}	100	300		$I_C = 10 \text{mA}, V_{CE} = 1.0 \text{V}$	
		60	_		$I_C = 50 \text{mA}, V_{CE} = 1.0 \text{V}$	
		30	_		$I_C = 100 \text{mA}, V_{CE} = 1.0 \text{V}$	
Collector-Emitter Saturation Voltage	V		0.20	V	$I_C = 10 \text{mA}, I_B = 1.0 \text{mA}$	
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	_	0.30	V	$I_C = 50 \text{mA}, I_B = 5.0 \text{mA}$	
Base-Emitter Saturation Voltage	V _{BE(SAT)}	0.65	0.85	V	$I_C = 10mA, I_B = 1.0mA$	
· ·		_	0.95	٧	$I_C = 50 \text{mA}, I_B = 5.0 \text{mA}$	
SMALL SIGNAL CHARACTERISTICS						
Output Capacitance	C_{obo}	_	4.0	pF	$V_{CB} = 5.0V$, $f = 1.0MHz$, $I_E = 0$	
Input Capacitance	Cibo	_	8.5	pF	$V_{EB} = 0.5V$, $f = 1.0MHz$, $I_{C} = 0$	
Input Impedance	h _{ie}	1.0	10	kΩ		
Voltage Feedback Ratio	h _{re}	0.5	8.0	x 10 ⁻⁴	$V_{CE} = 10V, I_{C} = 1.0mA,$	
Small Signal Current Gain	h _{fe}	100	400	_	f = 1.0kHz	
Output Admittance	h _{oe}	1.0	40	μS		
Current Gain-Bandwidth Product	f⊤	300	_	MHz	$V_{CE} = 20V, I_{C} = 10mA,$ f = 100MHz	
SWITCHING CHARACTERISTICS						
Delay Time	t _d	_	35	ns	$V_{CC} = 3.0V, I_C = 10mA,$	
Rise Time	t _r	_	35	ns	$V_{BE(off)} = -0.5V, I_{B1} = 1.0mA$	
Storage Time	ts		200	ns	$V_{CC} = 3.0V, I_C = 10mA,$	
Fall Time	t _f		50	ns	$I_{B1} = I_{B2} = 1.0 \text{mA}$	

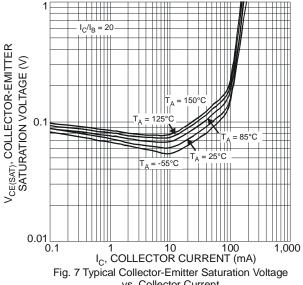
Notes: 4. Short duration pulse test used to minimize self-heating effect.





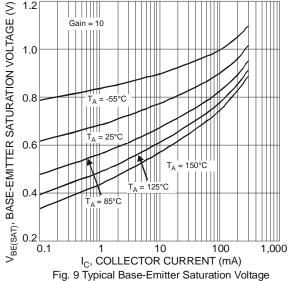






vs. Collector Current

1.2

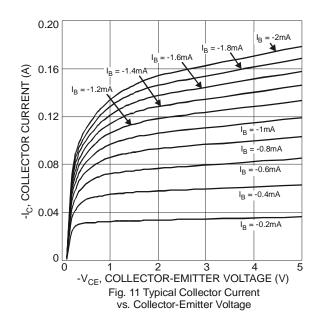


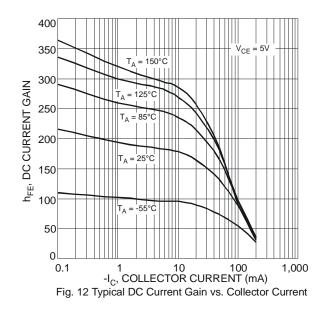


Electrical Characteristics - PNP (Q2) @TA = 25°C unless otherwise specified

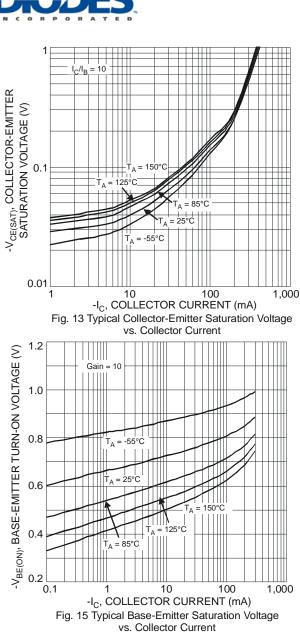
Characteristic	Symbol	Min	Max	Unit	Test Condition	
OFF CHARACTERISTICS						
Collector-Base Breakdown Voltage	V _{(BR)CBO}	-40		٧	$I_C = -10\mu A, I_E = 0$	
Collector-Emitter Breakdown Voltage (Note 4)	V _{(BR)CEO}	-40		V	$I_C = -1.0 \text{mA}, I_B = 0$	
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	-5.0		٧	$I_E = -10\mu A, I_C = 0$	
Collector Cutoff Current	I _{CEX}	_	-50	nA	$V_{CE} = -30V, V_{EB(OFF)} = -3.0V$	
Collector Cutoff Current	I _{CBO}	_	-50	nA	$V_{CE} = -30V, I_{E} = 0$	
Base Cutoff Current	I_{BL}	_	-50	nA	$V_{CE} = -30V, V_{EB(OFF)} = -3.0V$	
ON CHARACTERISTICS (Note 4)						
		60	_		$I_C = -100\mu A, V_{CE} = -1.0V$	
		80	_		$I_C = -1.0 \text{mA}, V_{CE} = -1.0 \text{V}$	
DC Current Gain	h _{FE}	100	300	_	$I_C = -10 \text{mA}, V_{CE} = -1.0 \text{V}$	
		60	_		$I_C = -50 \text{mA}, V_{CE} = -1.0 \text{V}$	
		30			$I_C = -100 \text{mA}, V_{CE} = -1.0 \text{V}$	
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	_	-0.25	V	$I_C = -10 \text{mA}, I_B = -1.0 \text{mA}$	
Composer Emmer Catalana Foliage			-0.40		$I_C = -50 \text{mA}, I_B = -5.0 \text{mA}$	
Base-Emitter Saturation Voltage	V _{BE(SAT)}	-0.65	-0.85	V	$I_C = -10 \text{mA}, I_B = -1.0 \text{mA}$	
, and the second		_	-0.95		$I_C = -50 \text{mA}, I_B = -5.0 \text{mA}$	
SMALL SIGNAL CHARACTERISTICS					T	
Output Capacitance	C _{obo}		4.5	pF	$V_{CB} = -5.0V$, $f = 1.0MHz$, $I_E = 0$	
Input Capacitance	C _{ibo}		10	pF	$V_{EB} = -0.5V$, $f = 1.0MHz$, $I_C = 0$	
Input Impedance	h _{ie}	2.0	12	kΩ		
Voltage Feedback Ratio	h _{re}	0.1	10	x 10 ⁻⁴	$V_{CE} = 10V, I_{C} = 1.0mA,$	
Small Signal Current Gain	h _{fe}	100	400	_	f = 1.0kHz	
Output Admittance	h _{oe}	3.0	60	μS]	
Current Gain-Bandwidth Product	f⊤	300		MHz	$V_{CE} = -20V, I_{C} = -10mA,$ f = 100MHz	
SWITCHING CHARACTERISTICS						
Delay Time	t _d	_	35	ns	$V_{CC} = -3.0V, I_{C} = -10mA,$	
Rise Time	t _r	_	35	ns	$V_{BE(off)} = 0.5V, I_{B1} = -1.0mA$	
Storage Time	ts	_	225	ns	$V_{CC} = -3.0V, I_{C} = -10mA,$	
Fall Time	t _f		75	ns	$I_{B1} = I_{B2} = -1.0 \text{mA}$	

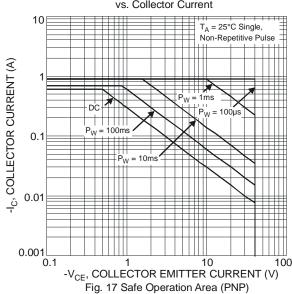
Notes: 4. Short duration pulse test used to minimize self-heating effect.

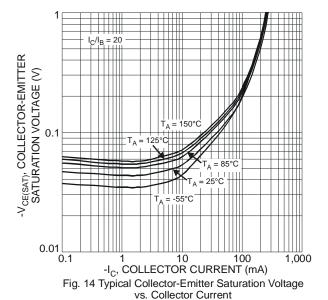












1.2

Gain = 10

O.8

T_A = .55°C

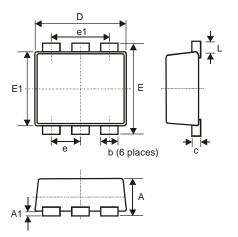
T_A = 150°C

T_A = 15

vs. Collector Current

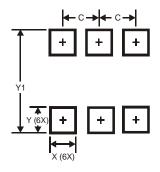


Package Outline Dimensions



SOT-963					
Dim	Min	Max	Тур		
Α	0.40	0.50	0.45		
A1	0	0.05	-		
С	0.120	0.180	0.150		
D	0.95	1.05	1.00		
Е	0.95	1.05	1.00		
E1	0.75	0.85	0.80		
١	0.05	0.15	0.10		
b	0.10	0.20	0.15		
е	0.35 Typ				
e1	e1 0.70 Typ				
All Dimensions in mm					

Suggested Pad Layout



Dimensions	Value (in mm)
С	0.350
Х	0.200
Υ	0.200
Y1	1.100



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